

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/669,442	BAEK ET AL.	
	<b>Examiner</b>	Art Unit	
	Leonid Shapiro	2629	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
THE AS ABOVE	SAME	05.26.06	LC